



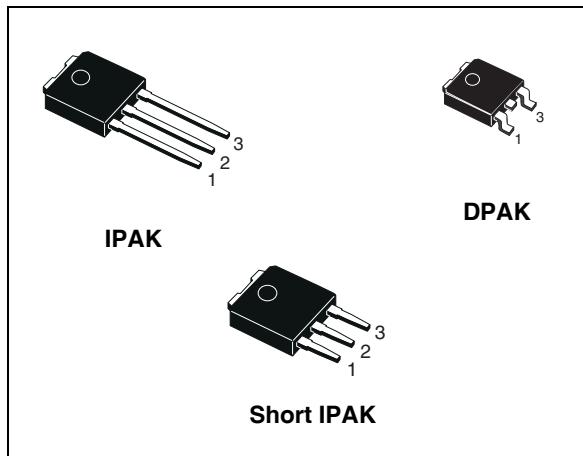
# STD75N3LLH6 STU75N3LLH6, STU75N3LLH6-S

N-channel 30 V, 0.0042  $\Omega$ , 75 A, DPAK, IPAK, Short IPAK  
STripFET™ VI DeepGATE™ Power MOSFET

## Features

Type	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STD75N3LLH6	30 V	< 0.0055 $\Omega$	75 A
STU75N3LLH6	30 V	< 0.0059 $\Omega$	75 A
STU75N3LLH6-S	30 V	< 0.0059 $\Omega$	75 A

- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power losses



## Application

- Switching applications

## Description

This product utilizes the 6th generation of design rules of ST's proprietary STripFET™ technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

Figure 1. Internal schematic diagram

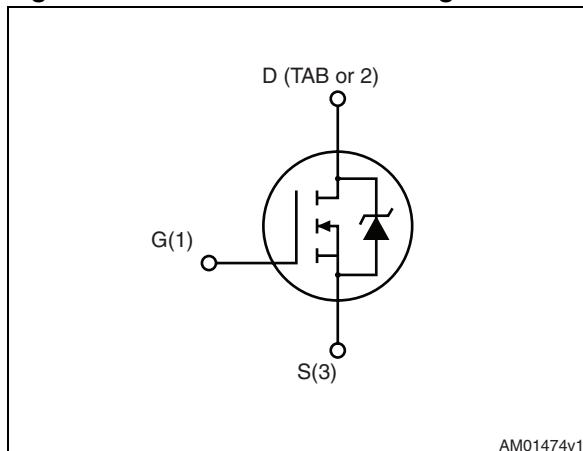


Table 1. Device summary

Order code	Marking	Package	Packaging
STD75N3LLH6	75N3LLH6	DPAK	Tape and reel
STU75N3LLH6	75N3LLH6	IPAK	Tube
STU75N3LLH6-S	75N3LLH6	Short IPAK	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{GS} = 0$ )	30	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	75	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	47	A
$I_{DM}^{(2)}$	Drain current (pulsed)	300	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	60	W
	Derating factor	0.4	W/ $^\circ\text{C}$
$T_j$ $T_{stg}$	Operating junction temperature storage temperature	-55 to 175	$^\circ\text{C}$

1. The value is rated according to  $R_{thj}$ -case
2. Pulse width limited by safe operating area

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case (drain) (steady state)	2.5	$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb max	31.2	$^\circ\text{C/W}$
$T_J$	Maximum lead temperature for soldering purpose	275	$^\circ\text{C}$

1. When mounted on FR-4 board of 1in<sup>2</sup>, 2oz Cu. t < 10 sec

## 2 Electrical characteristics

( $T_{CASE}=25^\circ\text{C}$  unless otherwise specified)

**Table 4. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0$	30			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 30 \text{ V}$ $V_{DS} = 30 \text{ V} T_C = 125^\circ\text{C}$			1 10	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20 \text{ V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1		2.5	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 37.5 \text{ A}$ SMD version		0.0042	0.0055	$\Omega$
		$V_{GS} = 10 \text{ V}, I_D = 37.5 \text{ A}$		0.0046	0.0059	$\Omega$
		$V_{GS} = 4.5 \text{ V}, I_D = 37.5 \text{ A}$ SMD version		0.0065	0.008	$\Omega$
		$V_{GS} = 4.5 \text{ V}, I_D = 37.5 \text{ A}$		0.0069	0.0084	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance			1690		pF
$C_{oss}$	Output capacitance	$V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0$	-	290	-	pF
$C_{rss}$	Reverse transfer capacitance			176		pF
$Q_g$	Total gate charge			17		nC
$Q_{gs}$	Gate-source charge	$V_{DD} = 15 \text{ V}, I_D = 75 \text{ A}, V_{GS} = 4.5 \text{ V}$	-	8	-	nC
$Q_{gd}$	Gate-drain charge	(see <a href="#">Figure 14</a> )		6		nC
$R_G$	Gate input resistance	f=1 MHz gate bias Bias=0 test signal level=20 mV open drain	-	1.7	-	$\Omega$

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 15 \text{ V}$ , $I_D = 37.5 \text{ A}$ $R_G = 4.7 \Omega$ $V_{GS} = 5 \text{ V}$ (see <a href="#">Figure 13</a> )	-	9.5	-	ns
$t_r$	Rise time			30		ns
$t_{d(off)}$	Turn-off delay time			37	-	ns
$t_f$	Fall time			12		ns

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		75	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				300	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 37.5 \text{ A}$ , $V_{GS} = 0$	-		1.1	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 75 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 24 \text{ V}$ (see <a href="#">Figure 15</a> )	-	24	ns	nC
$Q_{rr}$	Reverse recovery charge			16.8		
$I_{RRM}$	Reverse recovery current			1.4		

1. Pulse width limited by safe operating area.
2. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

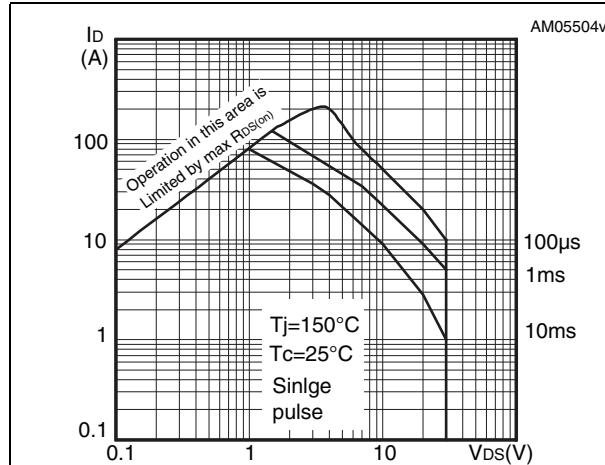


Figure 3. Thermal impedance

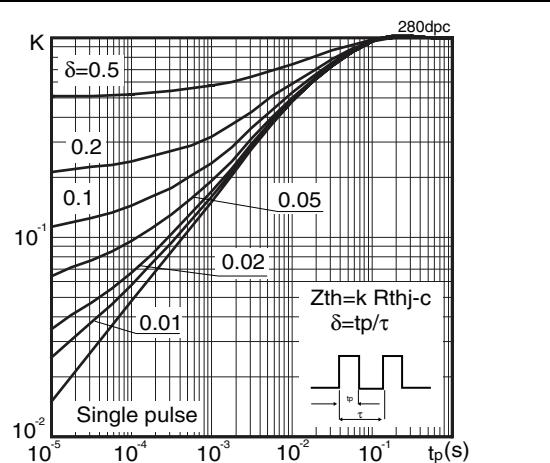


Figure 4. Output characteristics

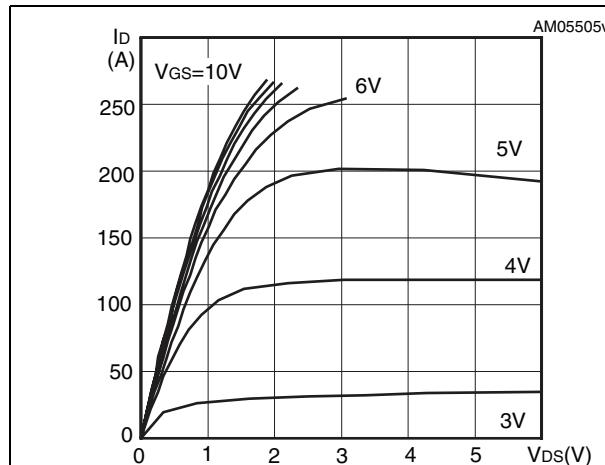


Figure 5. Transfer characteristics

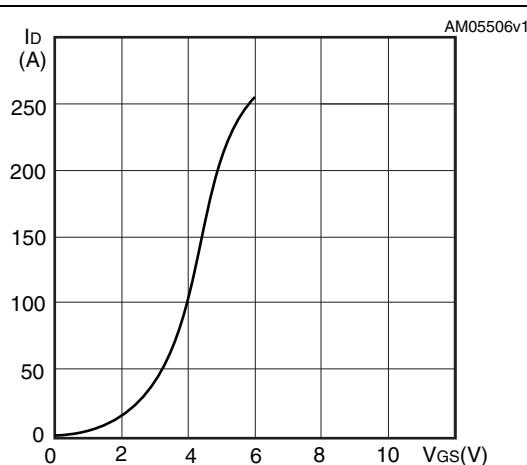
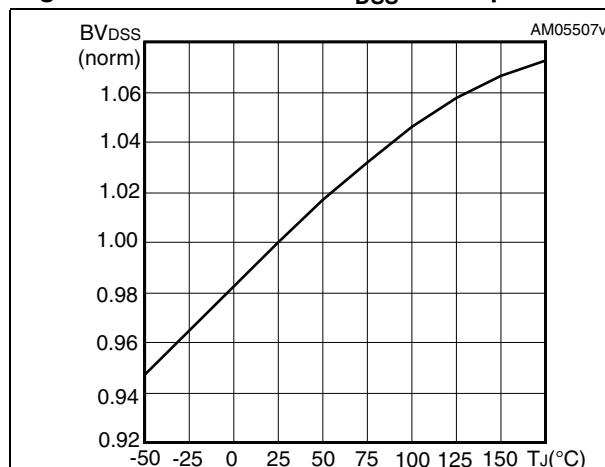
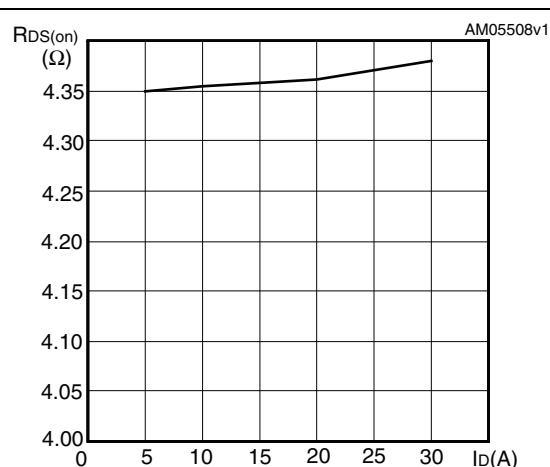
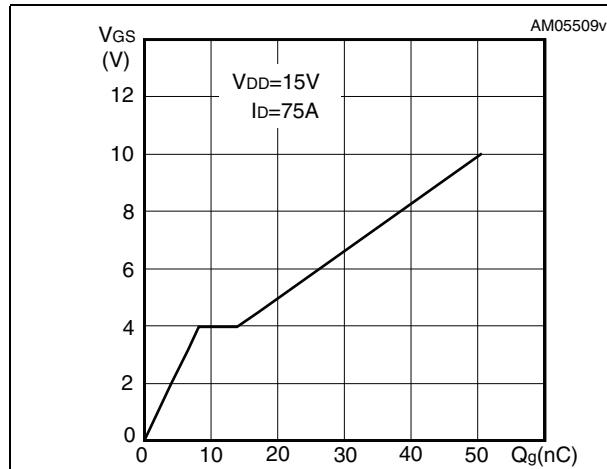
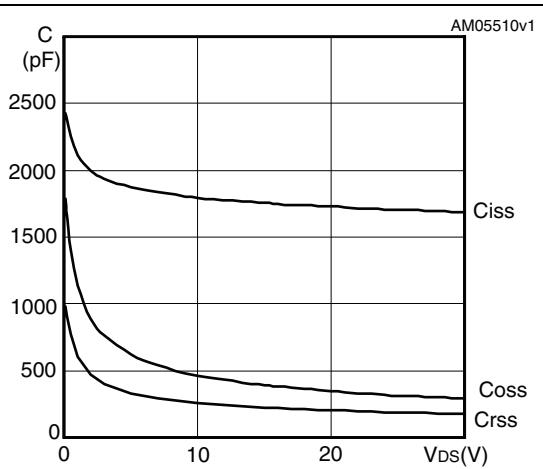
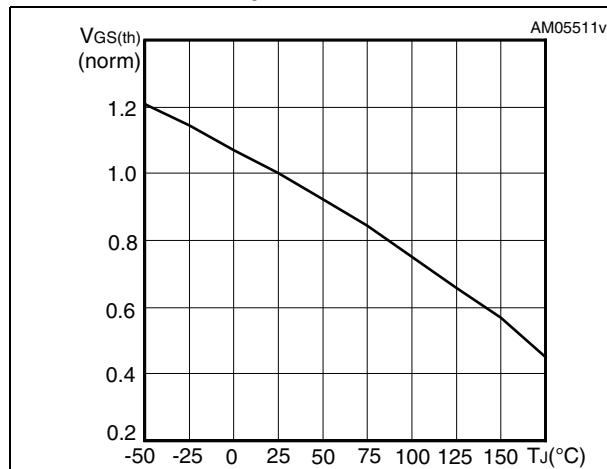
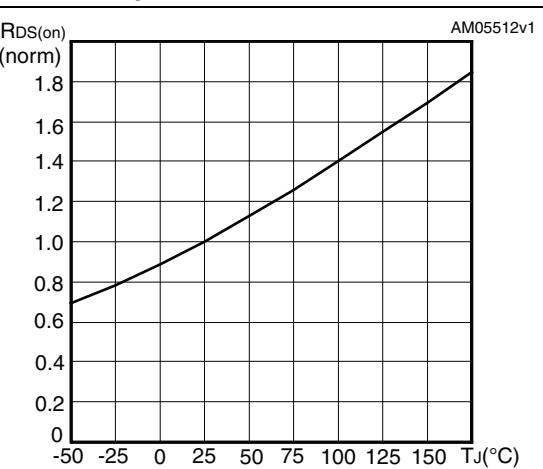
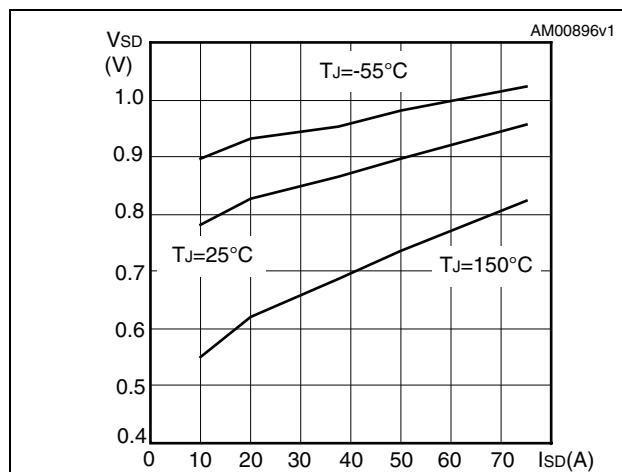
Figure 6. Normalized  $BV_{DSS}$  vs temperature

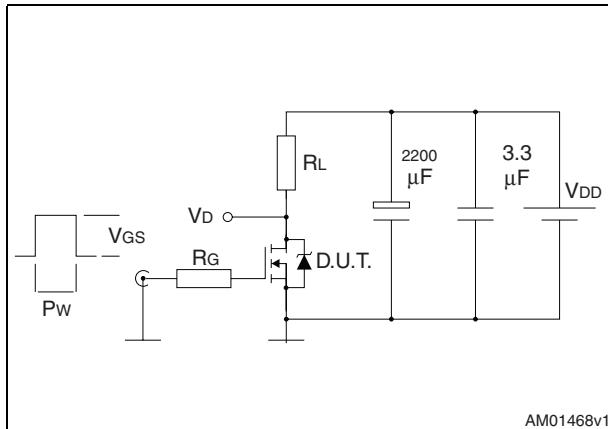
Figure 7. Static drain-source on resistance



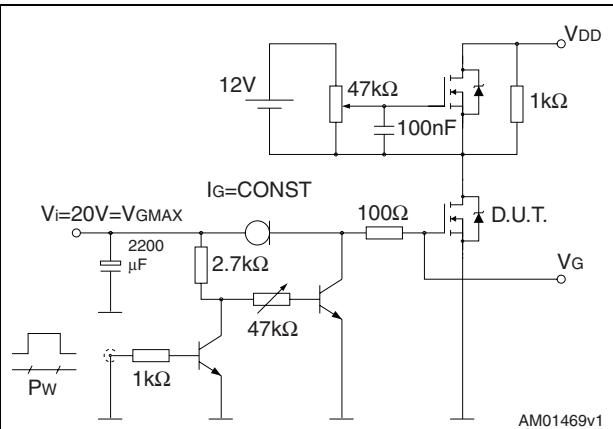
**Figure 8. Gate charge vs gate-source voltage****Figure 9. Capacitance variations****Figure 10. Normalized gate threshold voltage vs temperature****Figure 11. Normalized on resistance vs temperature****Figure 12. Source-drain diode forward characteristics**

### 3 Test circuits

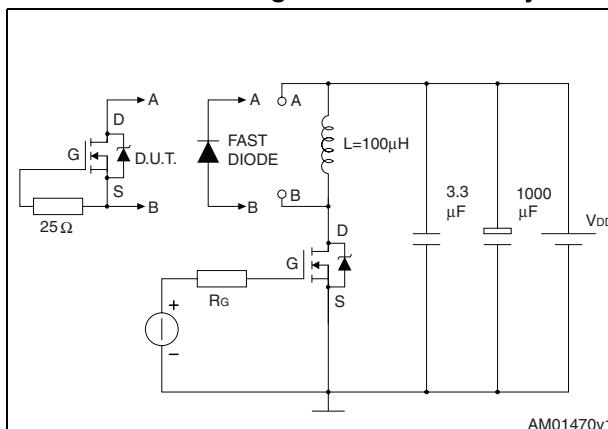
**Figure 13. Switching times test circuit for resistive load**



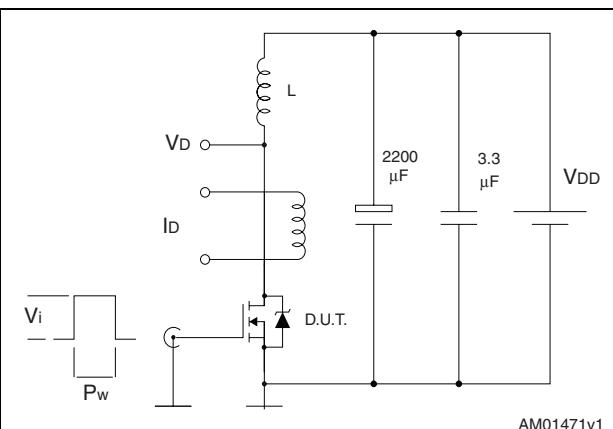
**Figure 14. Gate charge test circuit**



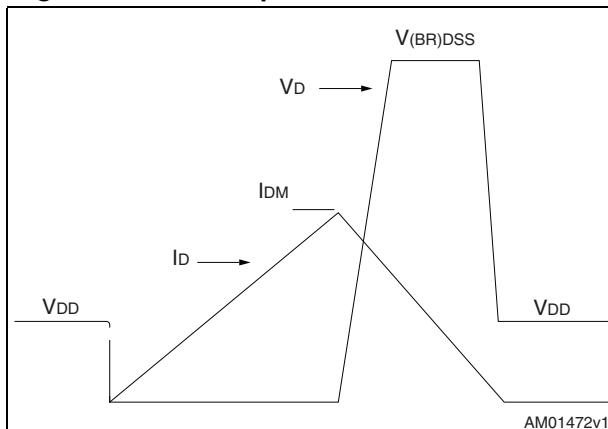
**Figure 15. Test circuit for inductive load switching and diode recovery times**



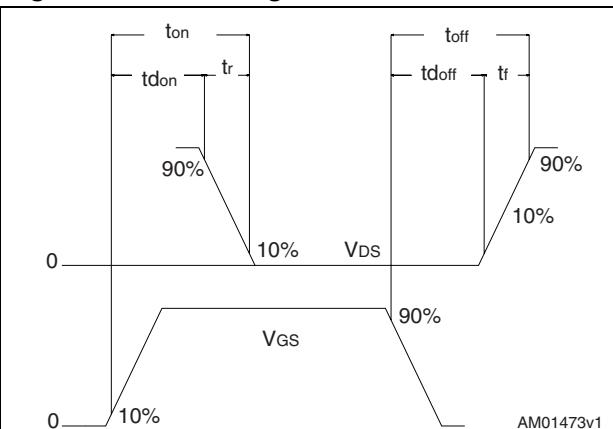
**Figure 16. Unclamped inductive load test circuit**

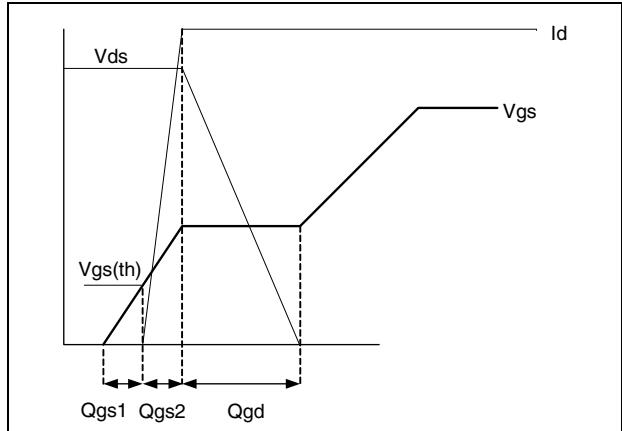


**Figure 17. Unclamped inductive waveform**



**Figure 18. Switching time waveform**



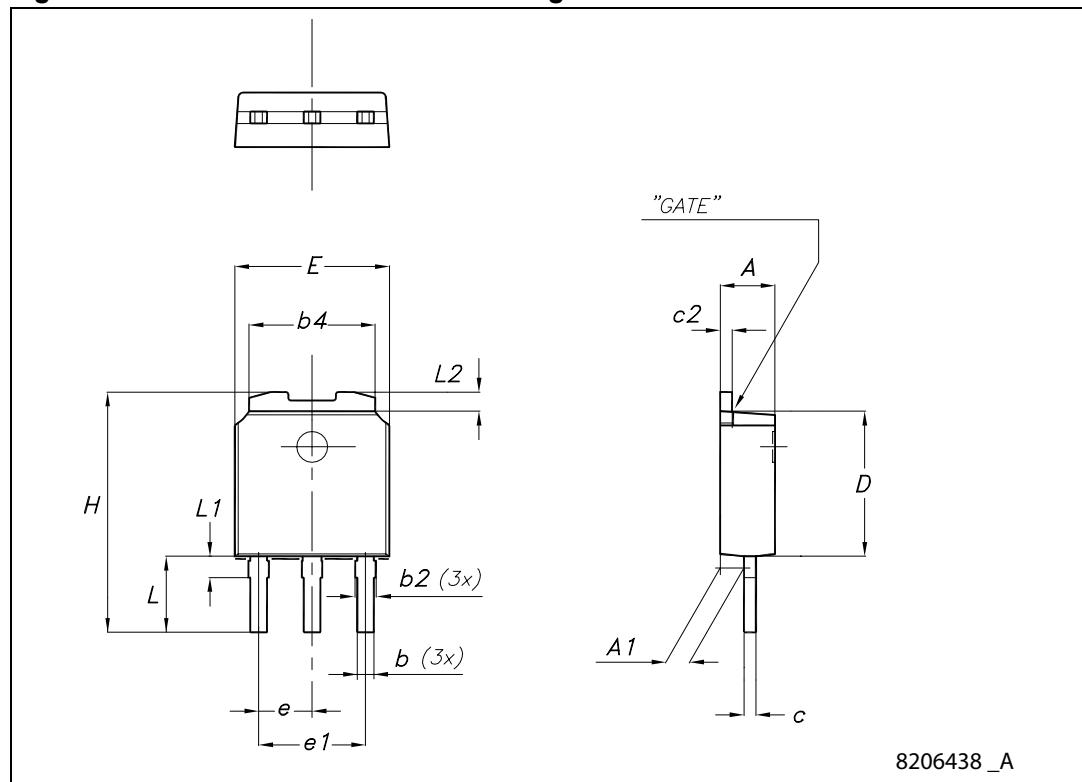
**Figure 19. Gate charge waveform**

## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK is an ST trademark.

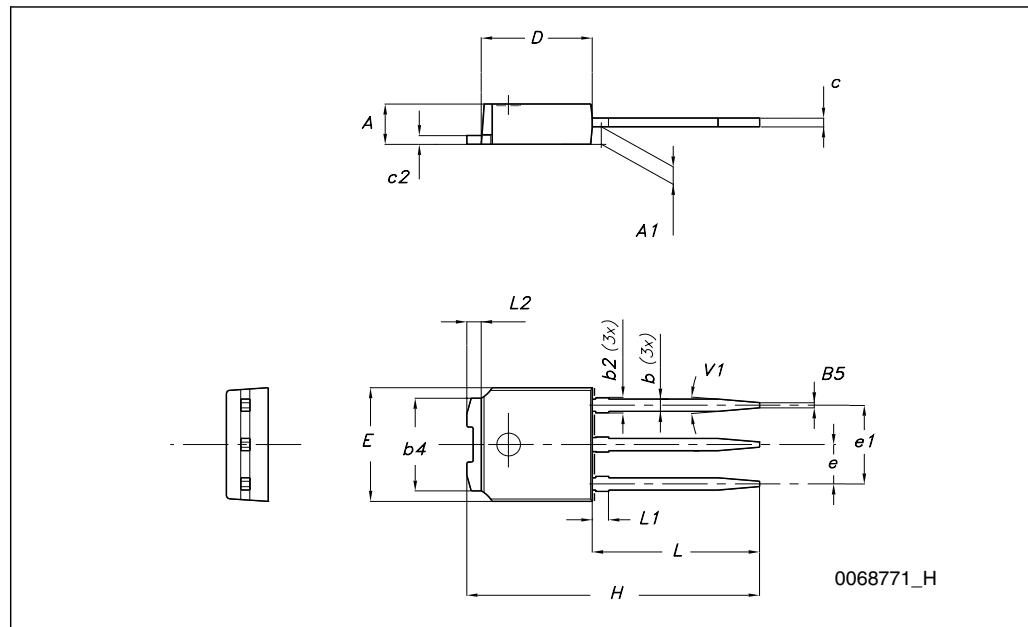
**Table 8. Short I-Pak mechanical dimensions**

Dim.	mm		
	Min	Typ	Max
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.25	
e1	4.40		4.60
H	9.80		10.40
L	3.00		3.40
L1	0.80		1.20
L2		0.80	1.00

**Figure 20. Short I-Pak mechanical drawing**

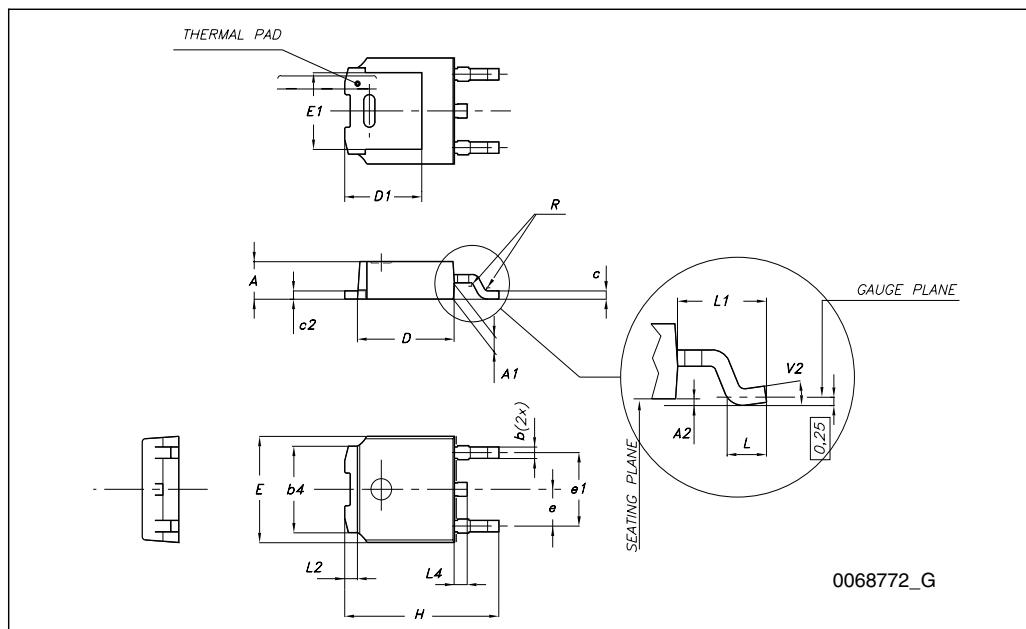
## TO-251 (IPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.28	
e1	4.40		4.60
H		16.10	
L	9.00		9.40
(L1)	0.80		1.20
L2		0.80	
V1		10°	



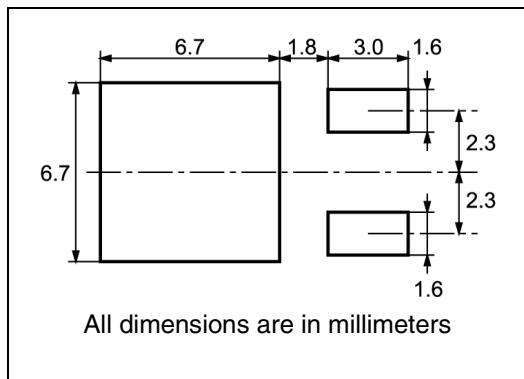
## TO-252 (DPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0 °		8 °

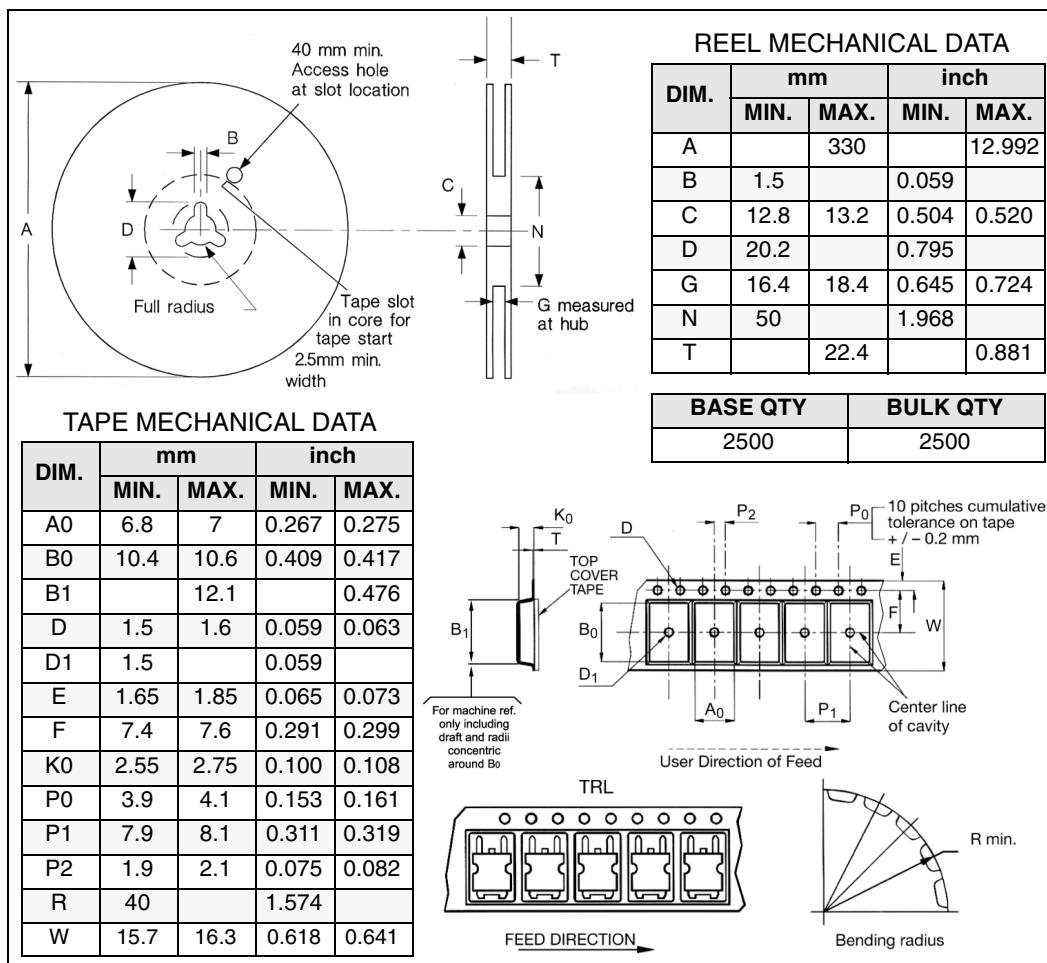


## 5 Packaging mechanical data

### DPAK FOOTPRINT



### TAPE AND REEL SHIPMENT



## 6 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
01-Jul-2009	1	First issue.
02-Oct-2009	2	<ul style="list-style-type: none"><li>– Added device in Short IPAK;</li><li>– document status promoted from preliminary data to datasheet.</li></ul>

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